

Steep Phase Gradients and Challenges in Materials Science Applications of X-Ray Phase Contrast Imaging

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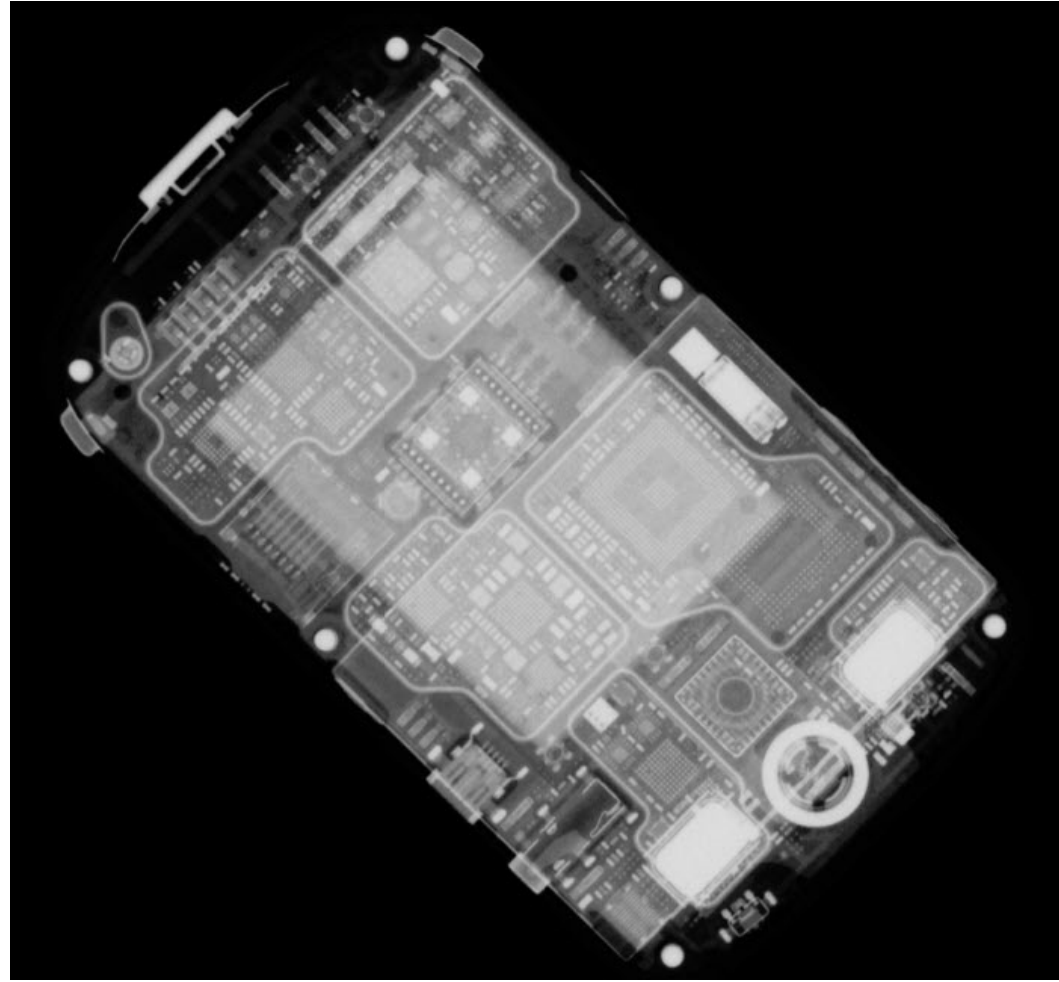
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SPIE Defense + Commercial Sensing
Anomaly Detection and Imaging with X-Rays (ADIX)
Conference 9847, Session 2
Tuesday, April 19, 2016



X-RAY PHASE CONTRAST IMAGING

X-ray Phase Contrast Imaging





Absorption

Contrast between dense and less-dense (low-Z) regions.
No material detail.



Phase Contrast

Fine structure within the low-Z regions.



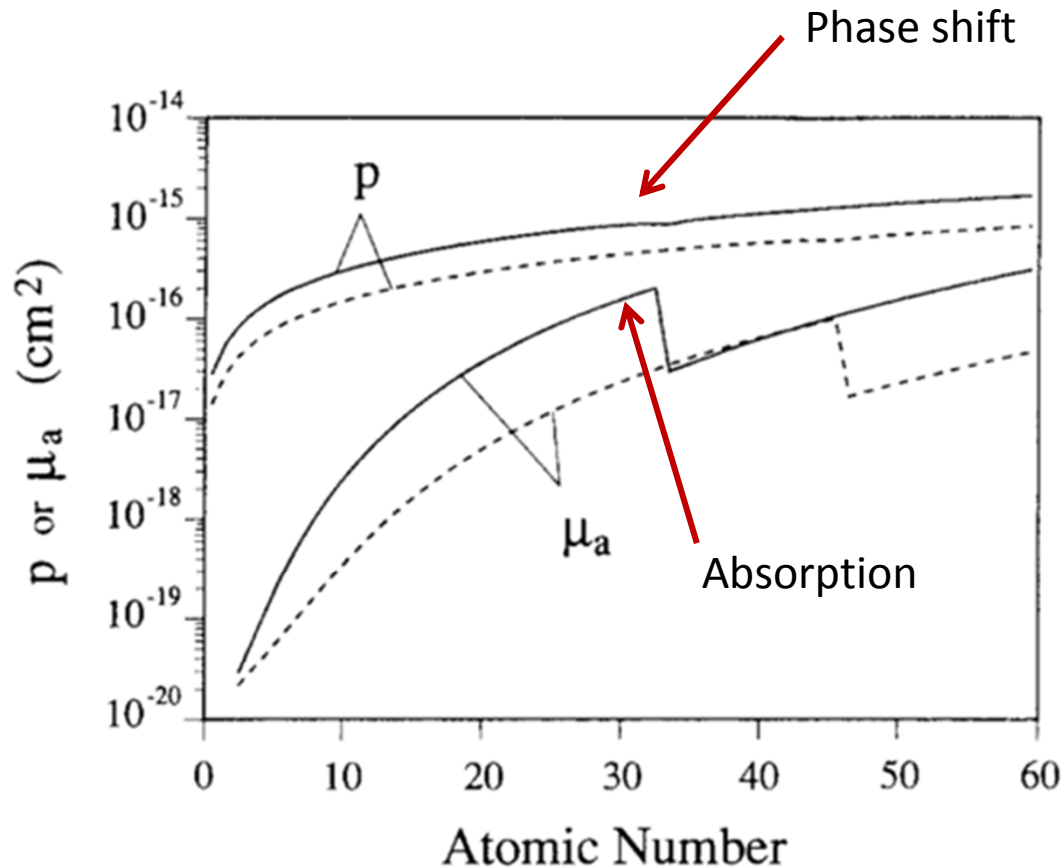
Dark-Field

Sharp contrast at boundaries.
Microstructures cause scattering.

To acquire only attenuation data leaves out significant information about the material properties

M. Bech, et. Al., Z. Med. Phys., **20**, 7, 2010.

Greater Sensitivity with Phase Contrast



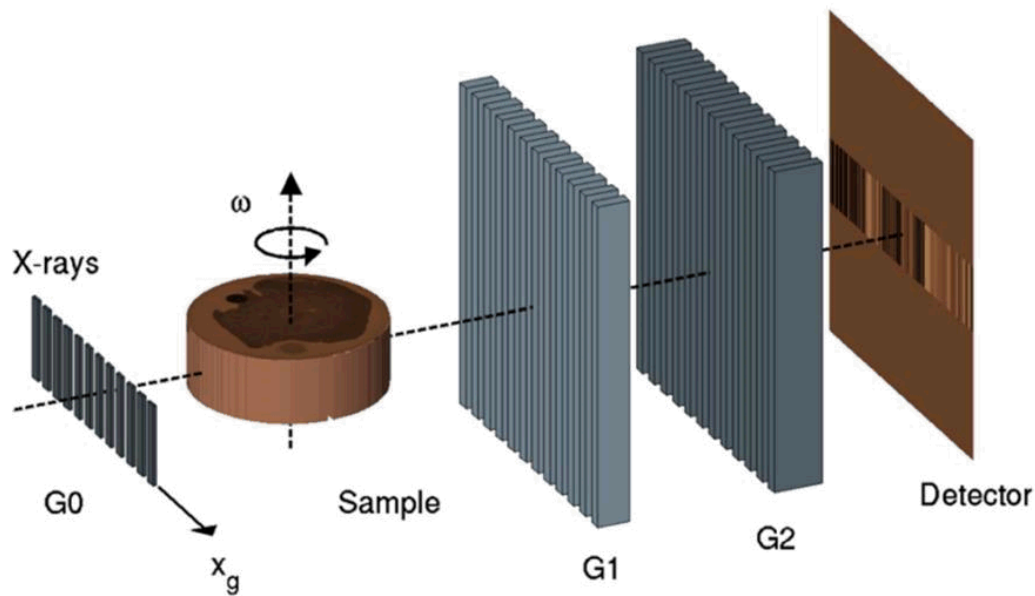
- X-ray absorption imaging is used for non-destructive imaging
- Poor sensitivity to low absorbing (low-Z) materials

Phase contrast
1000x more sensitive

FIG. 1. Atomic x-ray phase shift p and absorption μ_a for 1 Å (solid line) and 0.5 Å (dashed line) x-rays are plotted versus the atomic number Z . The value of p is almost a thousand times larger than μ_a for light elements.

Ref: A. Momose and J. Fukuda, Med. Phys., **22**, 375, 1995.

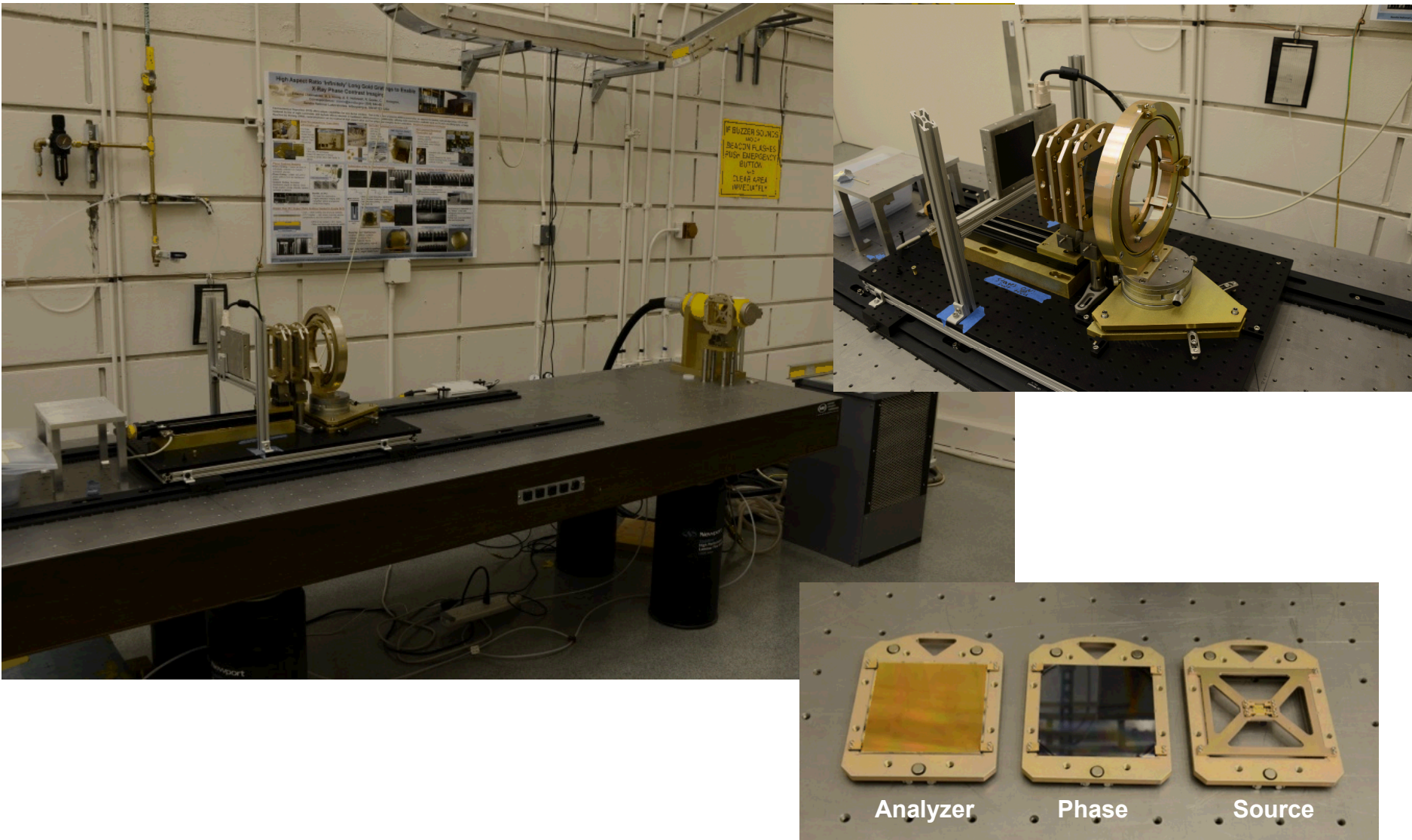
Talbot-Lau Interferometer



- Source grating: G0
 - Enables use of conventional x-ray tube
- Phase grating: G1
 - Imposes a modulated phase shift on wavefront
- Analyzer grating: G2
 - Converts narrow fringe pattern to intensity signal

**Source grating enables
lab-based XPCI**

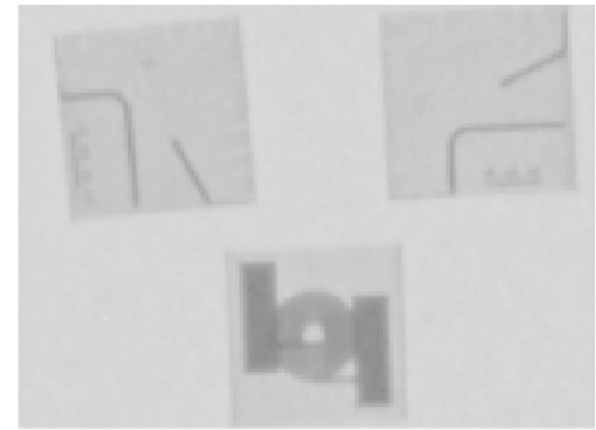
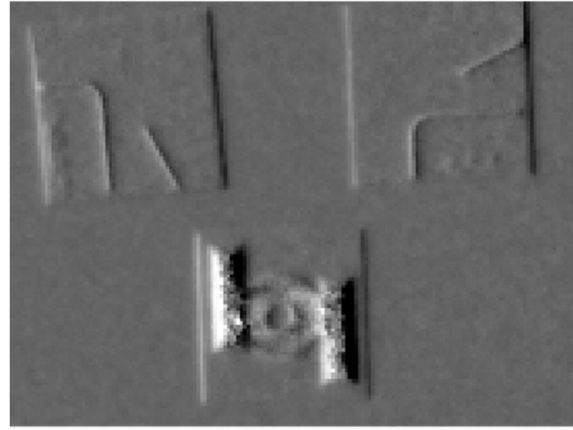
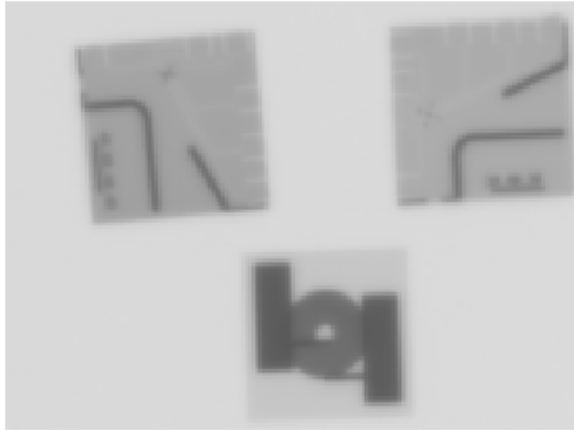
Laboratory Based System at Sandia



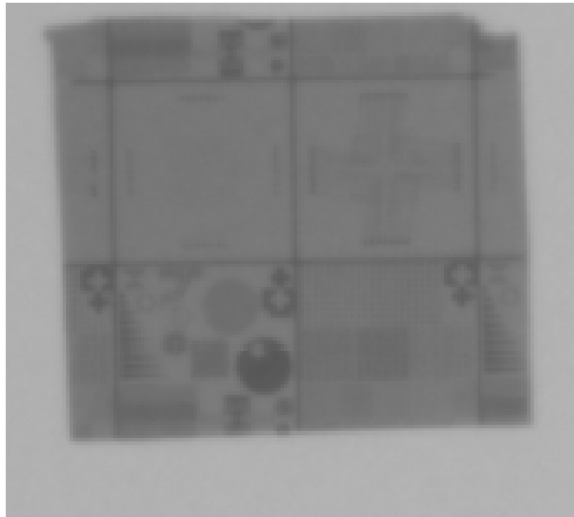
MATERIALS SCIENCE APPLICATIONS

Electroplated Gold and DRIE Etched Si MEMs

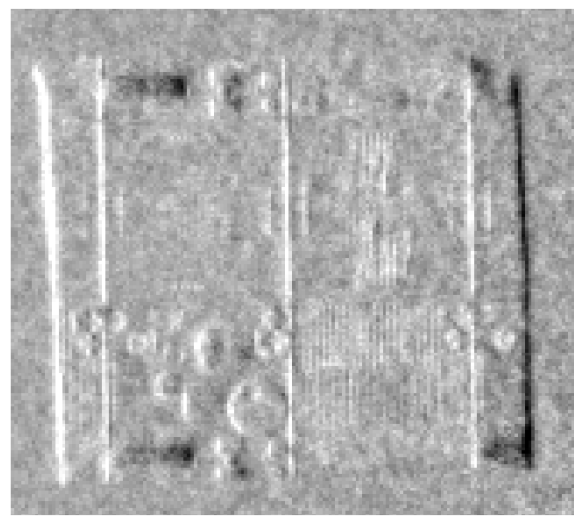
Gold electroplated magnetic coil and gold plated stylus ion trap



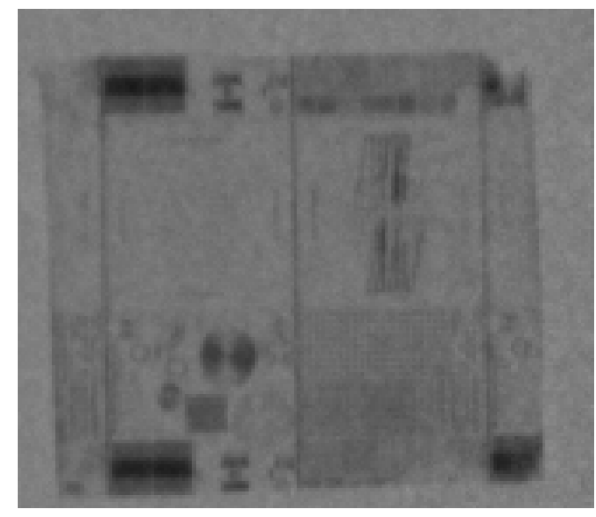
Deep reactive ion etched silicon MEMs



Absorption



Phase Contrast



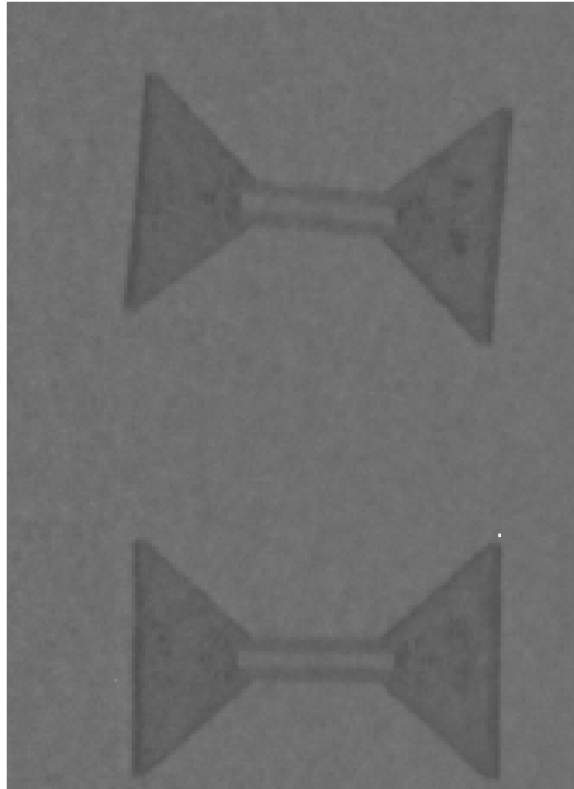
Dark Field

Microfabricated Ion Trap (not packaged)

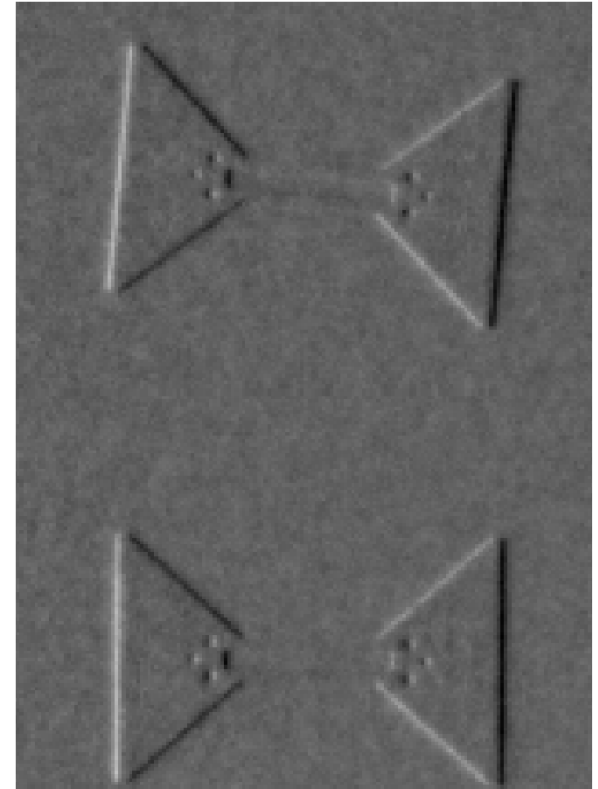
Transmission



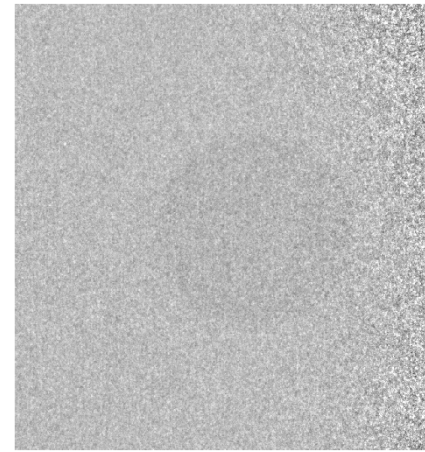
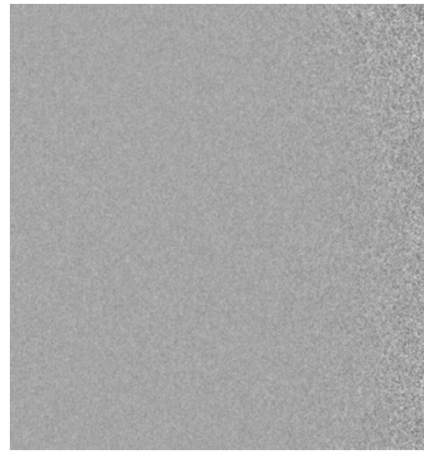
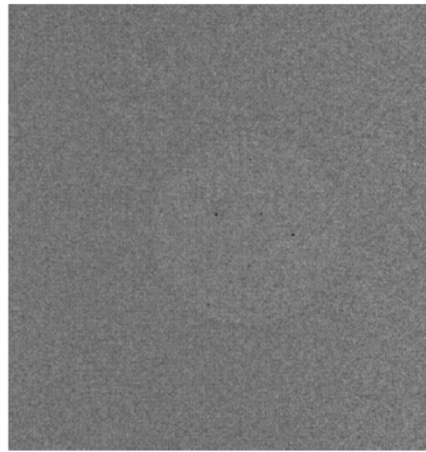
Dark Field



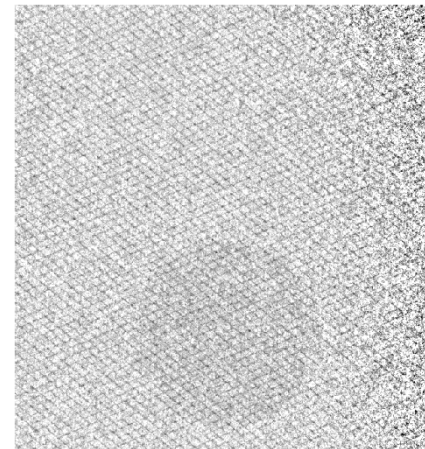
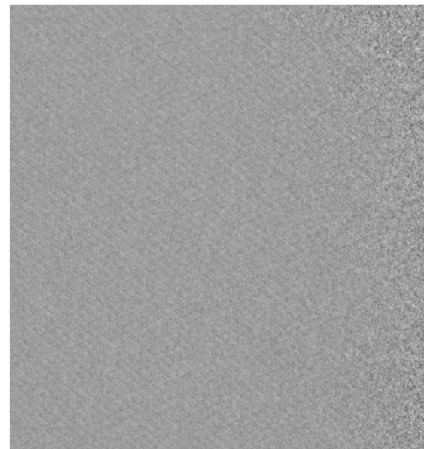
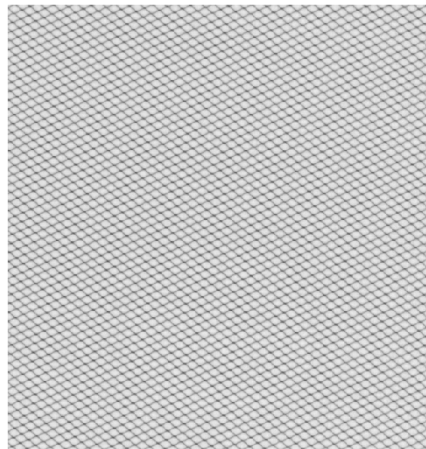
Differential Phase



Detection of Hidden Flaws in Aircraft Solid Laminate Composite Structure



Without
copper mesh



With copper
mesh

Absorption

Phase Contrast

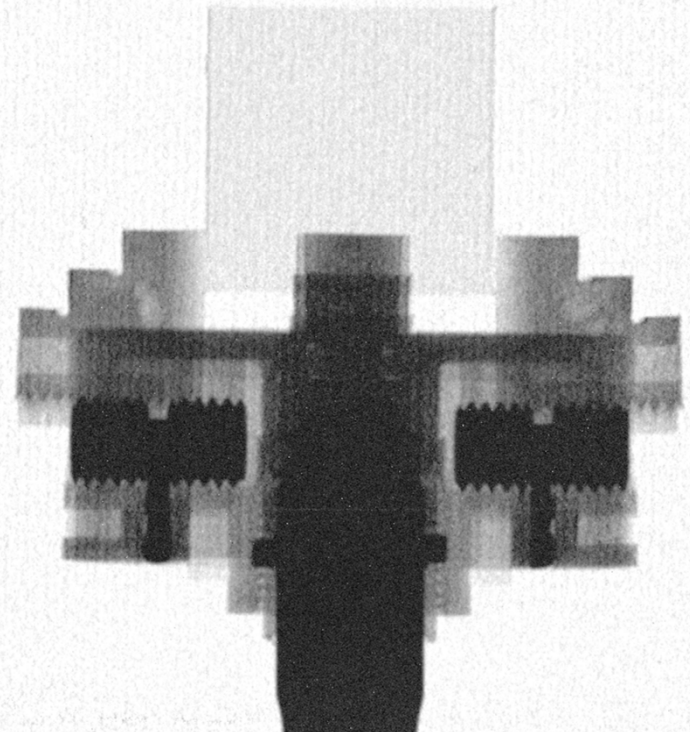
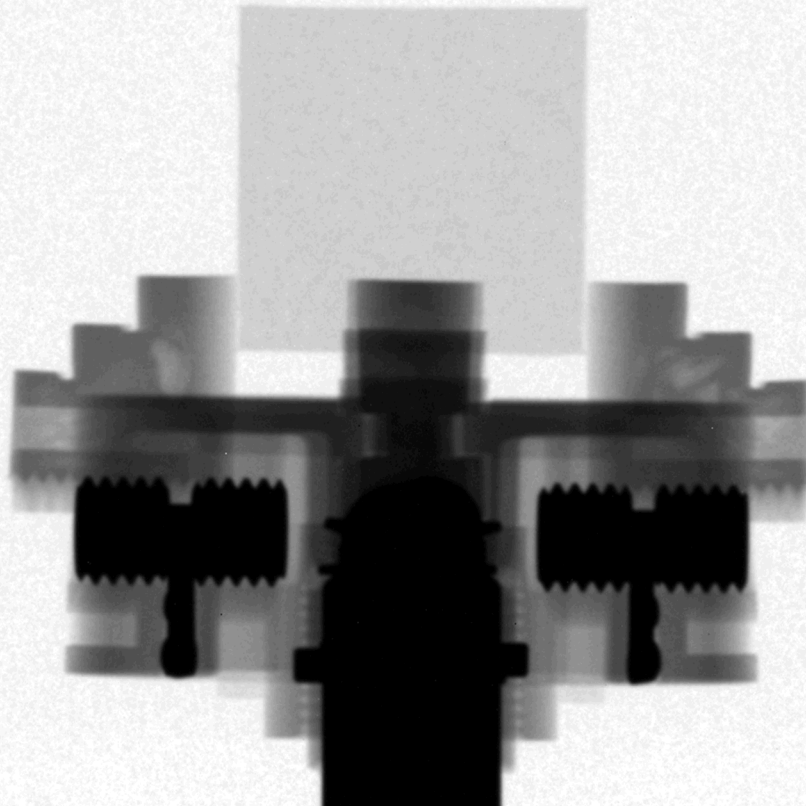
Dark Field

Flaw: GRAFOIL

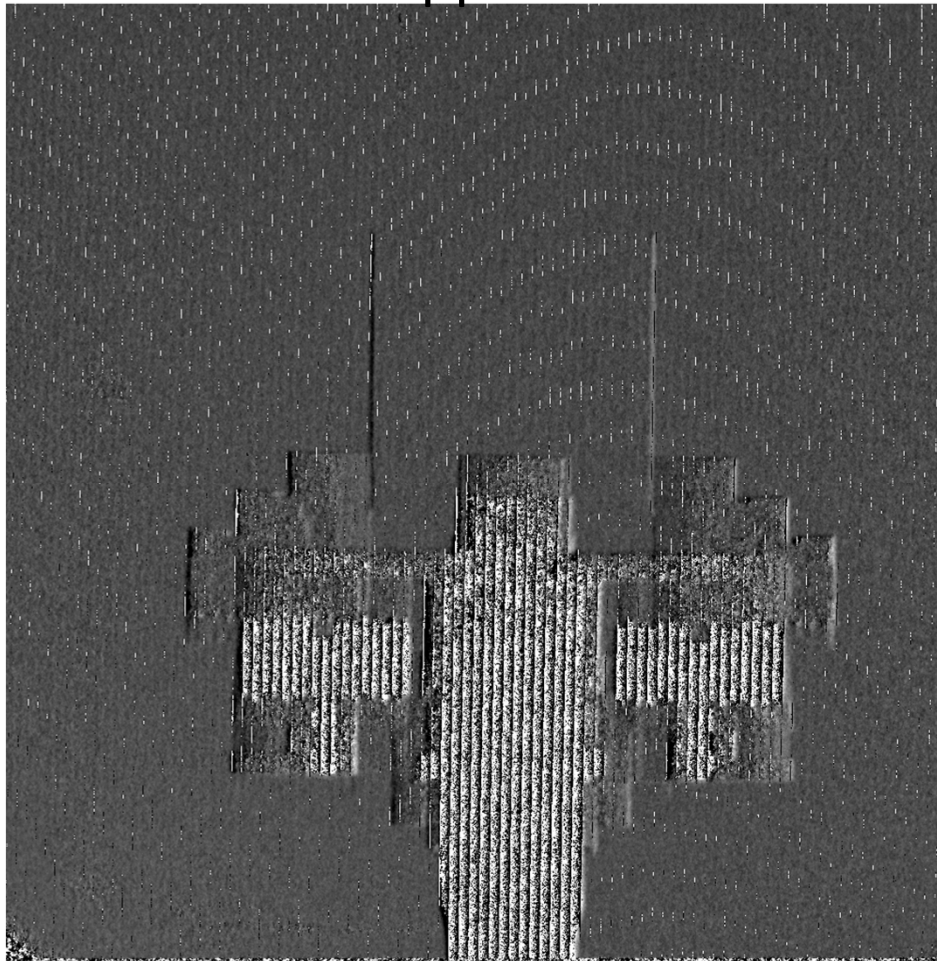
Additively Manufactured Plastic in Metal Mount

Transmission

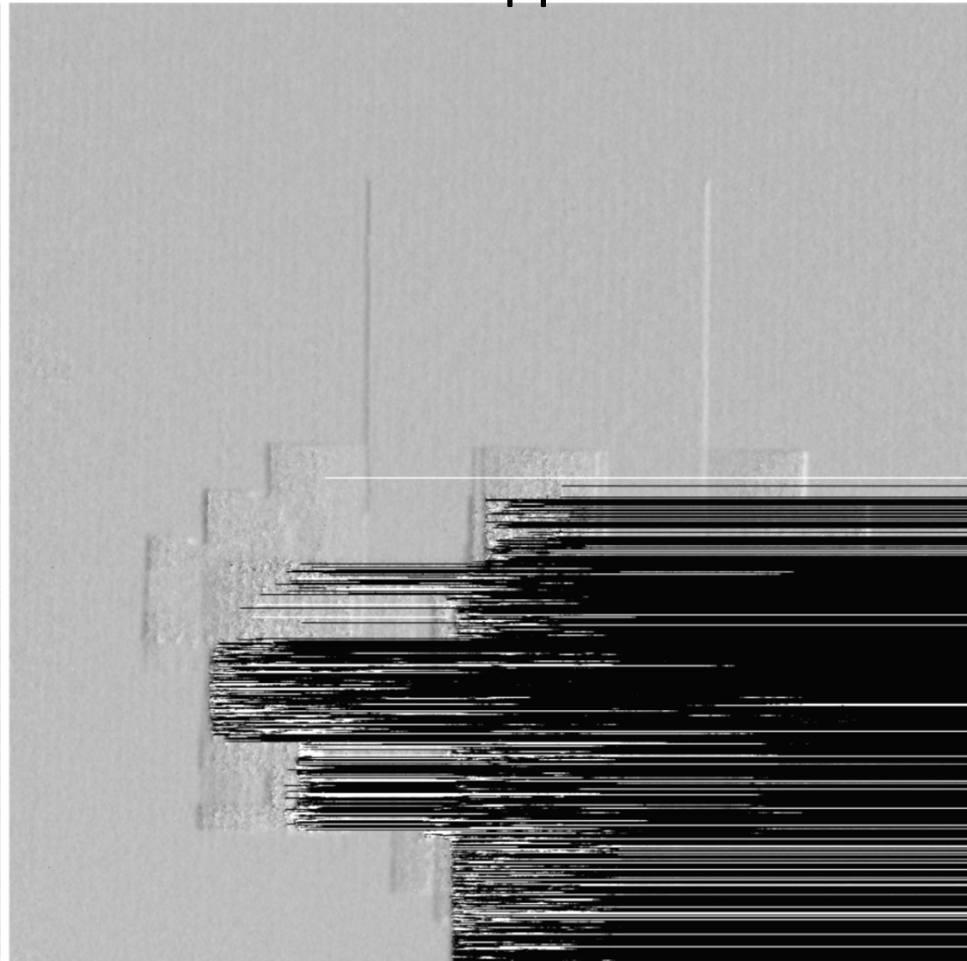
Dark Field

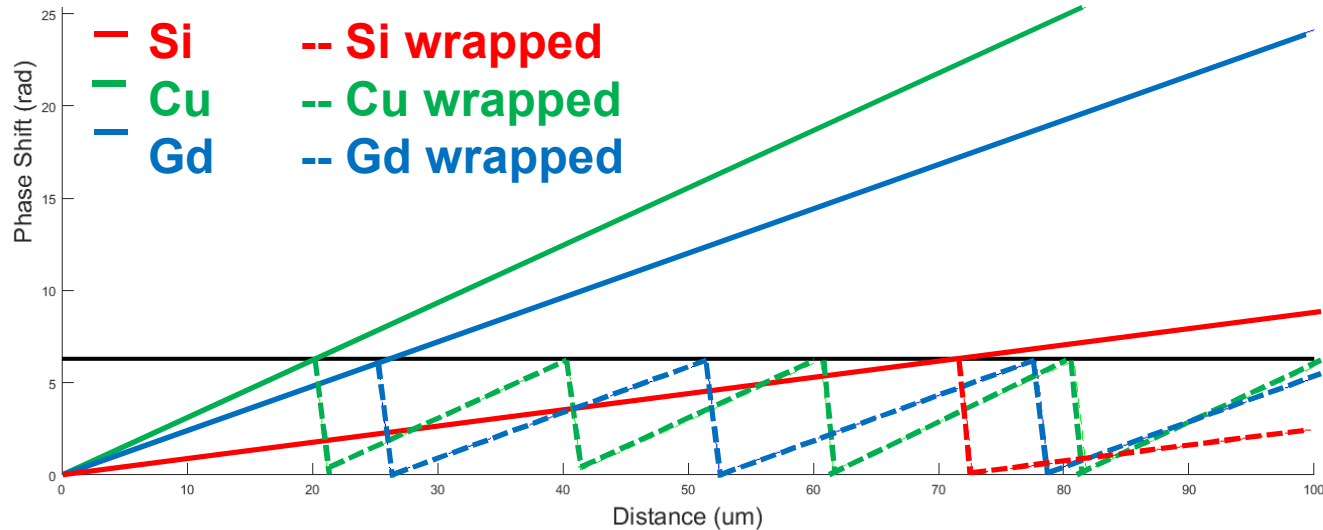


Wrapped Phase



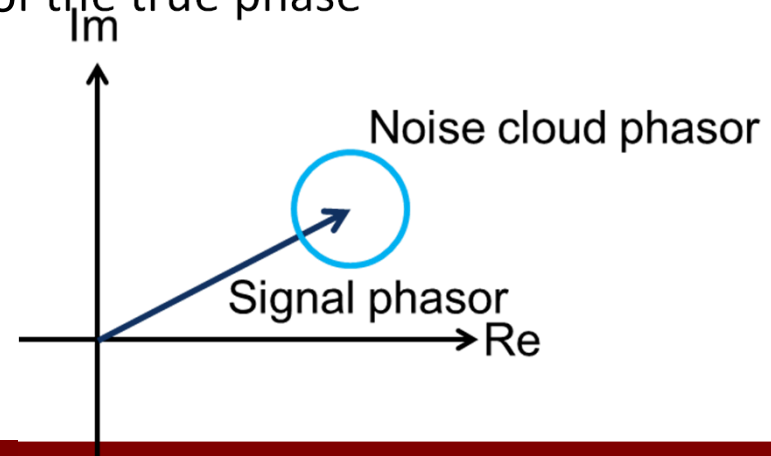
Unwrapped Phase



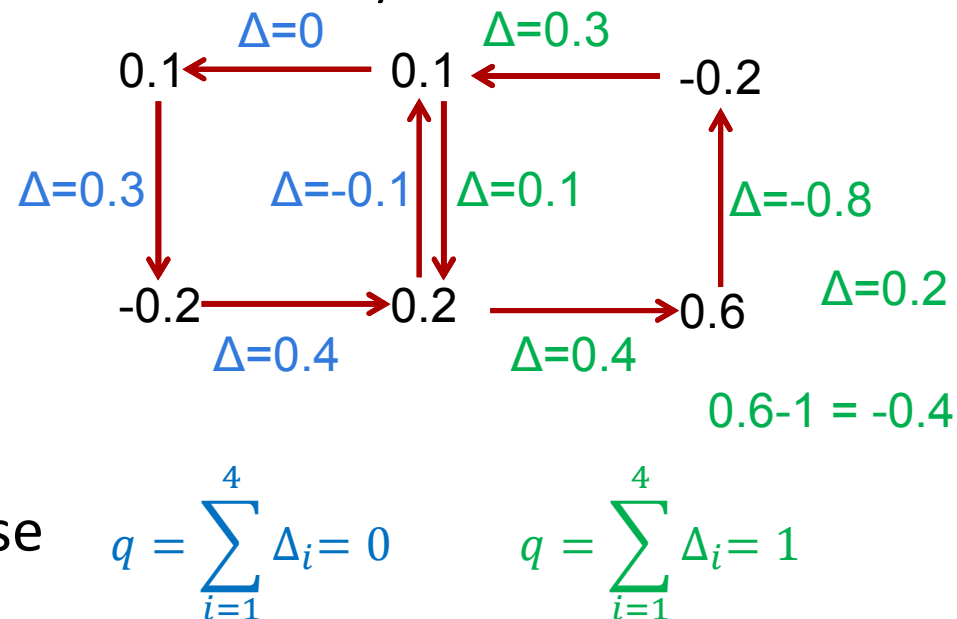


- Phase wrapping process is nonlinear
 - $\psi(x) = \varphi(x) + 2\pi k(x)$
 - k is an integer; $-\pi < \psi \leq \pi$
 - $\varphi(x)$ relates to some physical quantity
 - SAR: surface topography
 - XPCI: electron density/index of refraction
- Phase unwrapping problem: estimate $\phi(x)$ for $\varphi(x)$ from wrapped function $\psi(x)$

- Continuous phase stored digitally: incomplete representation
 - Measure continuous function at discrete points
 - Samples span a limited extent of total signal
 - Insufficient sample spacing may preclude reconstruction to a satisfying level of fidelity
 - Wrapped phase extracted from sampled signal may not allow unwrapping to any level of fidelity
- Noise can cause phase unwrapping failure
 - Unwrapping captures a noisy estimate of the true phase
 - Causes an effect analogous to aliasing



- Unwrapped phases can be obtained by integrating (summing) wrapped phase differences
 - Inconsistencies detected by summing wrapped phase differences (gradients) around every 2x2
 - Nyquist sampling: phase change constrained to π rads/sample
 - Helps localize source of each phase inconsistency
- Sources of residues
 - Zero magnitudes
 - Phase discontinuities
 - Noise
 - inconsistent phase gradients
 - Aliasing
- The existence of residues \rightarrow path-dependence in 2-D phase unwrapping



- If the phase or its gradient $\nabla\varphi$ satisfy conditions for path independence, phase unwrapping is path independent and task is trivial
 - Evaluate $\varphi(\vec{r}) = \int_C \nabla\varphi \cdot d\vec{r} + \varphi(\vec{r}_0)$ sequentially along a path that covers domain D.
- In real data, usually violate path independence
 - Need to choose a path that covers domain D and satisfies certain properties, OR
 - Use minimization criteria to get unwrapped phase estimates with explicitly satisfying an integration path
- Aliasing, singularities or noise can make phase unwrapping path dependent
 - All 2-D path following phase unwrapping algorithms are concerned with choosing a path

- Find a function whose unwrapped phase gradients are close to the measured wrapped phase gradients

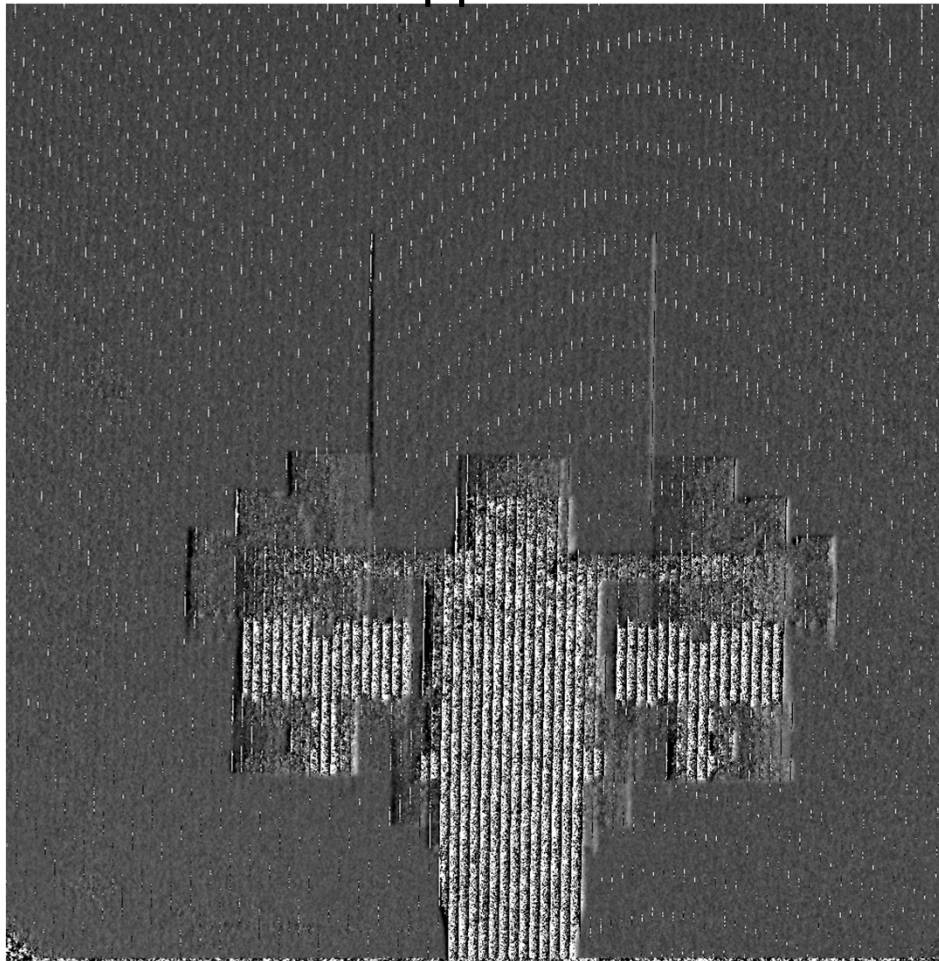
Global	Local
<ul style="list-style-type: none">Unwrap all simultaneouslyMinimum norm methods<ul style="list-style-type: none">Case: L2 norm: least squaresTransform (FFT,DCT)Matrix (weighting, nonlinear)FastSensitive to residuesCorruption spreads throughout imageDoesn't work well with	<ul style="list-style-type: none">Solve along a pathBranch cuts connect residues of opposite polarity; path doesn't crossFastEfficient if low phase noiseOptimization spatially incomplete in noisy regions

Network Flow

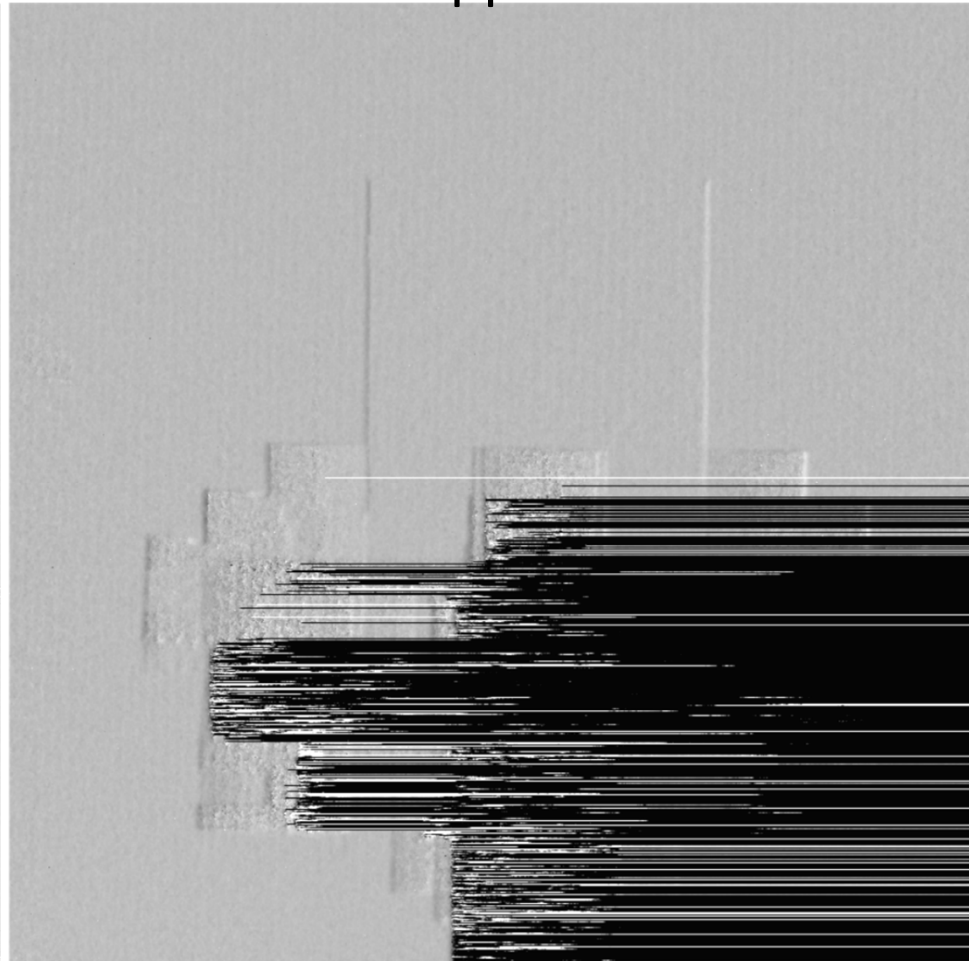
- Local path to calculate residues = node; node connected by arcs; look for optimal flow that minimizes sum for all arc flows
- Intensive memory usage and computational complexity

1-D Unwrapping is Insufficient

Wrapped Phase



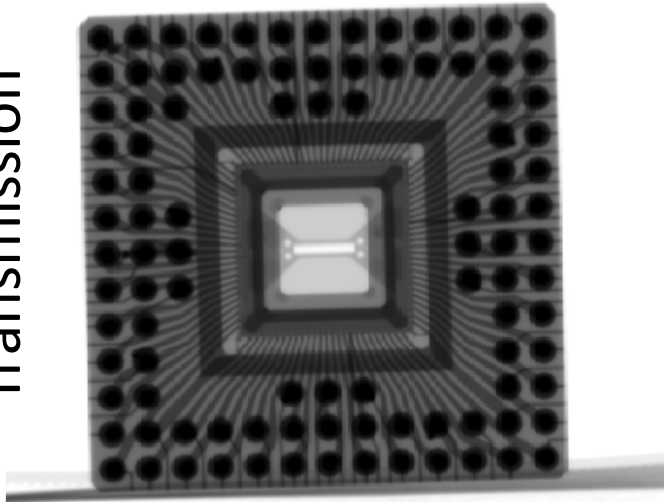
Unwrapped Phase



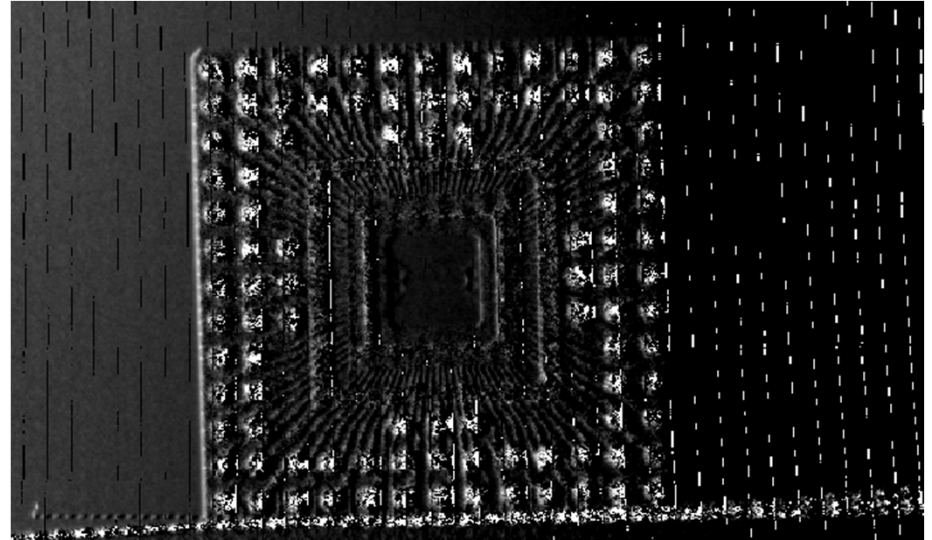
Advanced Phase Unwrapping Challenges

Packaged microfabricated surface electrode ion trap

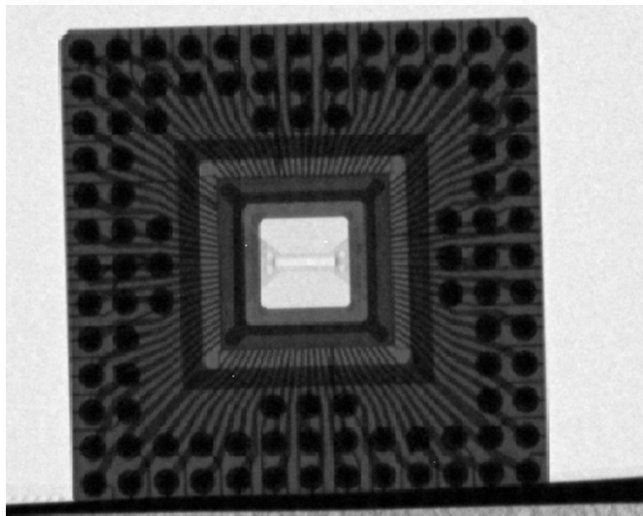
Transmission



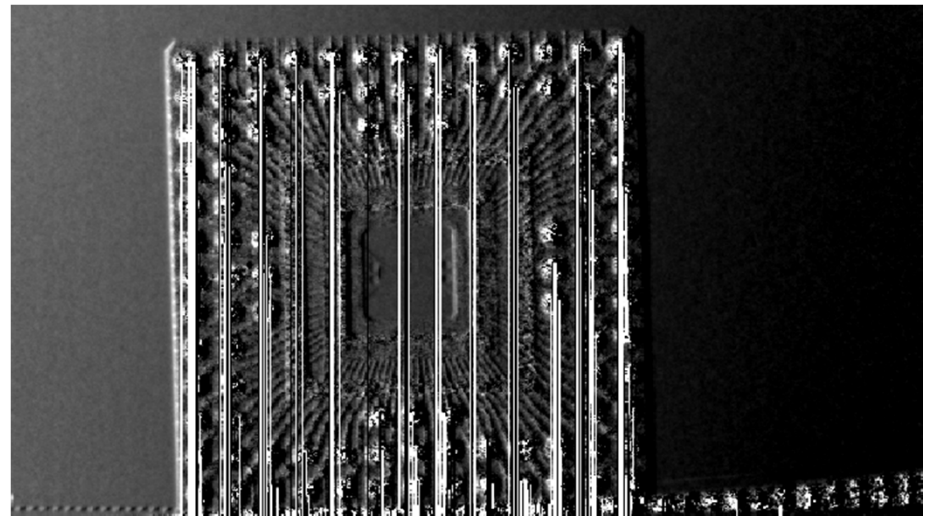
Wrapped Phase



Dark Field



Unwrapped Phase



- Inspection is critical to assuring functionality and security
 - “Slice and dice” inspection
 - Randomly selected samples
 - Labor intensive
 - Limited imaging depth
 - Complicated sample preparation
 - Limited in materials that can be inspected
- X-ray phase contrast imaging (XPCI)
 - Non-destructive
 - Three orders of magnitude greater sensitivity to phase over absorption imaging
 - Complementary imaging modalities (absorption, phase, dark-field)
 - Visualization of internal structure
 - Compare part topography to CAD design
 - Look for cracks, voids
 - Identify unfused powder
- Need advanced phase unwrapping algorithms

- Non-destructive
- Three orders of magnitude greater sensitivity to phase over absorption imaging
- Complementary imaging modalities (absorption, phase, dark-field)
- Visualization of internal structure
 - Compare part topography to CAD design
 - Look for cracks, voids, delaminations
- Need advanced phase unwrapping algorithms

Acknowledgements

Team: Christian Arrington, Patrick Finnegan, Ryan Goodner, Steven Grover, Andrew Hollowell, Jeffrey Hunker, Edward Jimenez, Collin Smith, Kyle Thompson

Project Manager: Brad Gabel

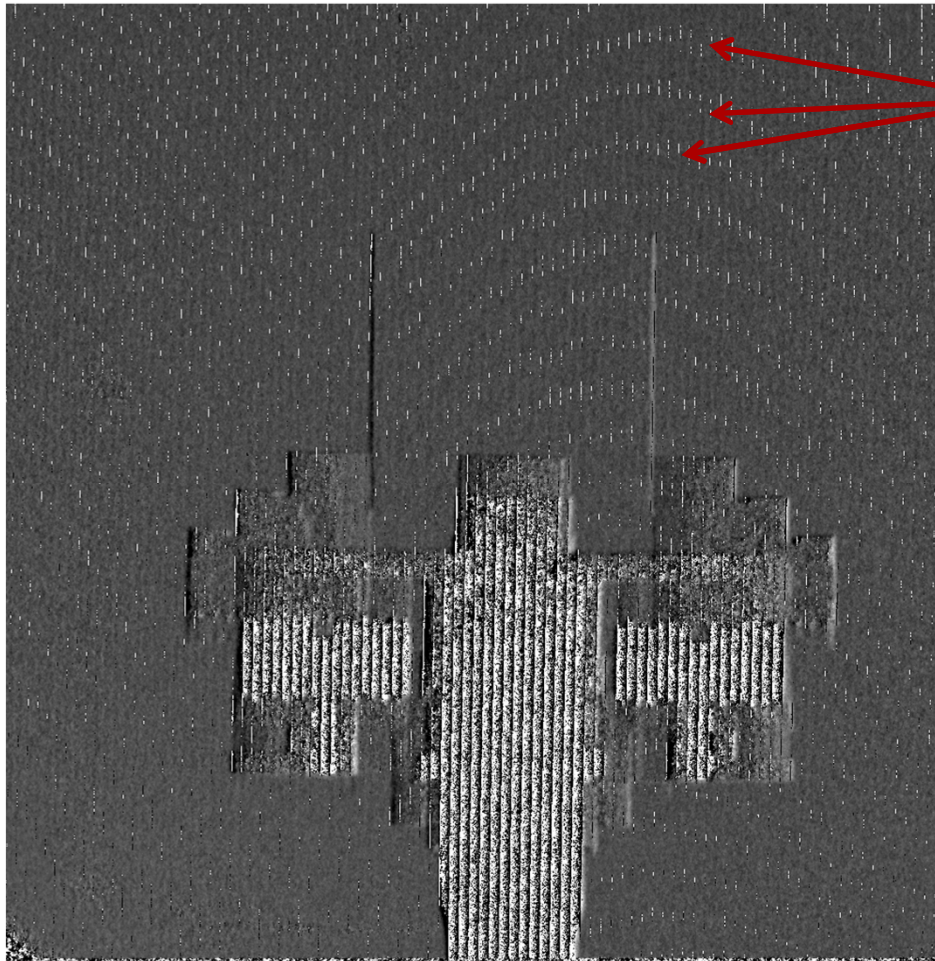
Funding: Laboratory Directed Research and Development (LDRD)

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BACK-UP SLIDES

Phase Unwrapping: Analogies to SAR



Cone beam geometry? aka flat earth

flat-earth phase is the phase present in the interferometric signal due to the curvature of the reference surface

Flat Earth Phase

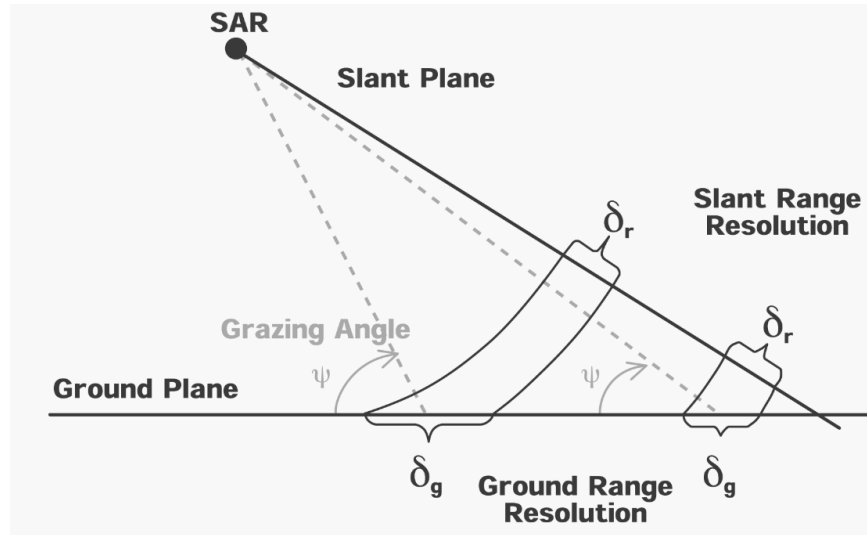
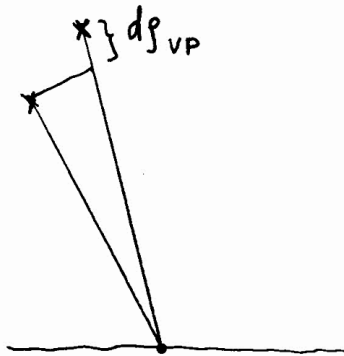
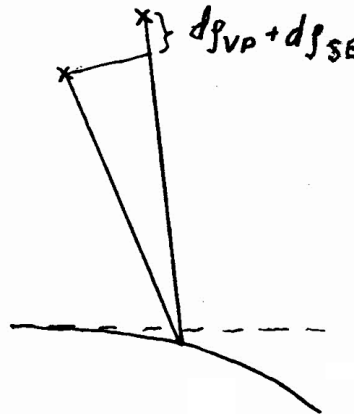


Figure 1.6. Slant plane and ground plane imaging geometry (flat earth).

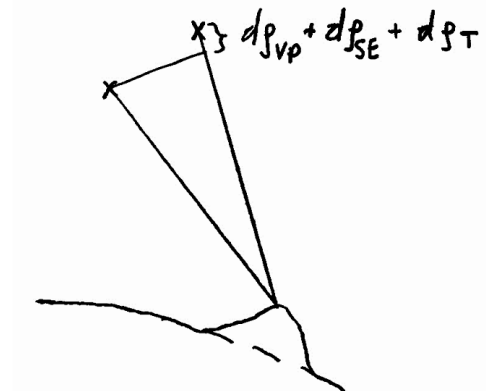
Viewing Position



Spherical Earth



Topography



Ref: Jackson, C.R., Chapter 1: Principles of Synthetic Aperture Radar from Radar Imaging Resources, Denver, CO

SAR interferogram

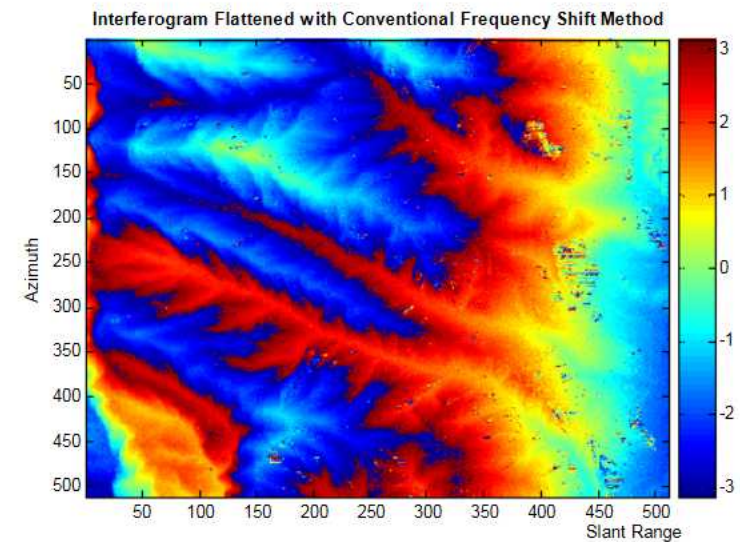
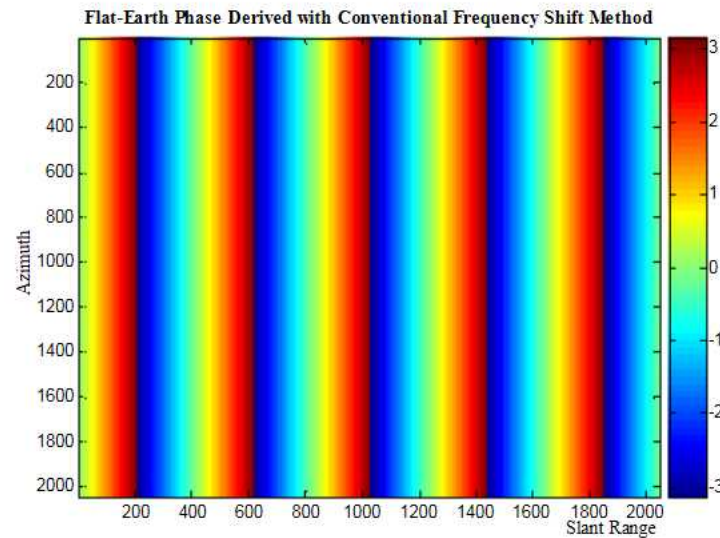
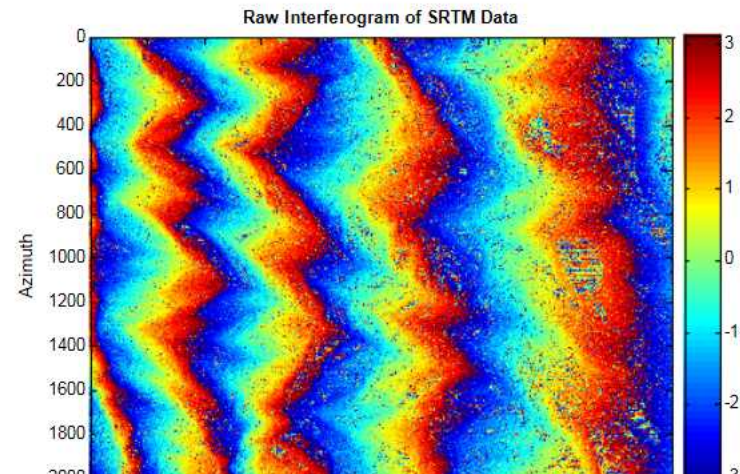
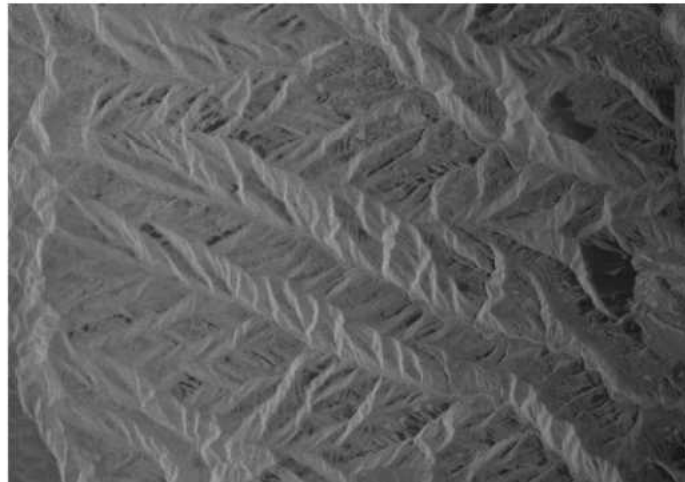


Fig 4 (a) Flat-earth phase Derived with Common Method. Fig.4 (b) Interferogram Flattened with Common Method.

Ai, B., Liu, K., Li, X. & Li, D. H. Flat-earth phase removal algorithm improved with frequency information of interferogram. In *Proc. SPIE 7147, Geoinformatics 2008 and Joint Conference on GIS and Built Environment: Classification of Remote Sensing Images 7147*, 71471A–71471A–10 (2008).



Cone beam geometry? aka flat earth

flat-earth phase:

the phase present in the interferometric signal due to the curvature of the reference surface

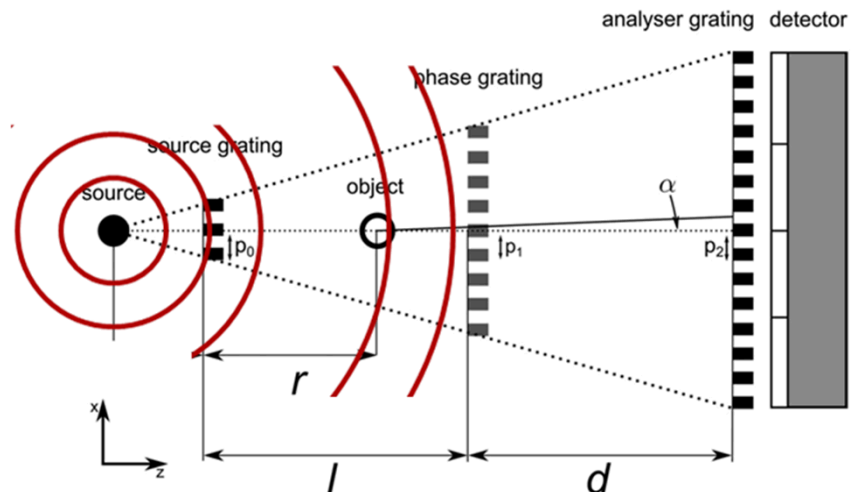


Figure adapted from: Birnbacher, L. *et al.* Experimental Realisation of Grating-based Phase-contrast Computed Tomography. *Sci. Rep.* **6**, 24022 (2016).